

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/022,122	DEKEL ET AL.	
				Examiner	Art Unit	
				Duy M. Dang	2624	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
382	232-233 240	8/25/2005	DD	East [USPTO,EPo,JPO,DERWENT], see printouts	8/25/2005	DD
382	244-248	8/25/2005	DD	Inventor search, see printouts	8/25/2005	dd
382	260-263	8/25/2005	DD			
382	284	8/25/2005	DD			
348	399	8/25/2005	DD			
703	247	8/25/2005	DD			
Updated	Above	11/21/06	DMS	Updated East tier Search	11/21/06	DMS
↓	↓	6/20/07	DMS			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			